CXP Receptacle Connectors

1. SCOPE

1.1. Content

This specification covers performance, tests and quality requirements for the TE Connectivity (TE) CXP receptacle connectors. These receptacle connectors are printed circuit board mounted and designed for intra-building use only.

1.2. Qualification

When tests are performed on the subject product line, procedures specified in Figure 1 shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

2.1. TE Documents

• 114-13283: Application Specification (CXP Connectors)

• 501-134023: Qualification Test Report (CXP Receptacle Connectors)

2.2. Industry Document

EIA-364: Electrical Connector/Socket Test Procedures Including Environmental Classifications

2.3. Reference Document

109-197: Test Specification (TE Test Specifications vs EIA and IEC Test Methods)

3. REQUIREMENTS

3.1. Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. Materials

Materials used in the construction of this product shall be as specified on the applicable product drawing.



3.3. Ratings

Voltage: 120 volts AC

Current: Signal application onlyTemperature: -40 to 85°C

3.4. Performance and Test Description

Product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions.

3.5. Test Requirements and Procedures Summary

Test Description	Requirement	Procedure			
Initial examination of product.	Meets requirements of product	EIA-364-18.			
	drawing and Application	Visual and dimensional (C of C)			
	Specification 114-13283.	inspection per product drawing.			
Final examination of product.	Meets visual requirements.	EIA-364-18.			
		Visual inspection.			
	ELECTRICAL				
Low Level Contact Resistance	80 milliohms maximum initial.	EIA-364-23.			
(LLCR).	ΔR 20 milliohms maximum for	Subject specimens to 100			
	signal contacts.	milliamperes maximum and 20			
		millivolts maximum open circuit			
		voltage.			
Insulation resistance.	1000 megohms minimum.	EIA-364-21.			
		500 volts DC, 2 minute hold.			
		Test between adjacent contacts.			
Withstanding voltage.	One minute hold with no breakdown	EIA-364-20, Condition I.			
	or flashover.	300 volts AC at sea level.			
		Test between adjacent contacts,			
		signal to ground as applicable.			
	MECHANICAL				
Random vibration.	No discontinuities of 1 microsecond	EIA-364-28, Test Condition VII,			
	or longer duration.	Condition Letter D.			
	See Note.	Subject mated specimens to 3.10			
		G's rms between 20 to 500 Hz.			
		Fifteen minutes in each of 3			
		mutually perpendicular planes.			
Mechanical shock.	No discontinuities of 1 microsecond	EIA-364-27, Method H.			
	or longer duration.	Subject mated specimens to 30 G's			
	See Note.	half-sine shock pulses of 11			
		milliseconds duration. Three shocks			
		in each direction applied along 3			
		mutually perpendicular planes, 18			
		total shocks.			

Figure 1 (cont'd)

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Test Description	Requirement	Procedure		
Durability	See Note.	EIA-364-9.		
		Manually mate and unmate		
		specimens (as indicated in		
		Figure 2) at a maximum rate of 300		
		cycles per hour with latches		
		engaged and 2 transceivers per test		
		sequence.		
Mating force.	150 N [33.7 lbf] maximum.	EIA-364-13.		
		Measure force necessary to mate		
		specimens with latches engaged at		
		a maximum rate of 6.35 mm [.25 in]		
		per minute.		
Unmating force.	65 N [14.5 lbf] maximum.	EIA-364-13.		
-		Measure force necessary to unmate		
		specimens with latches disengaged		
		at a maximum rate of 6.35 mm [.25		
		in] per minute.		
Retention, axial.	100 N [22.5 lbf] minimum.	Apply axial load to mated		
		specimens with latch engaged.		
	without unmating.			
Retention, perpendicular.	70 N [15.5 lbf] minimum.	Apply perpendicular load in all 4		
71 1	No functional damage to mated pair	directions to mated specimens with		
	without unmating.	latch engaged.		
Latch strength.	180 N [40.5 lbf] minimum.	EIA-364-98.		
	No functional damage to latch	Apply axial load to specimens with		
	below 180 N. Separation of mated	latch engaged.		
	pair is acceptable.			
Press fit insertion force.	24.5N [5.5 lbf] maximum, per pin	Measure force necessary to press		
		specimens onto PCB into proper		
		seating location.		
Press fit extraction force.	93.4 N [21 lbf] minimum.	Measure force necessary to extract		
		specimens from PCB with hardware		
		removed.		
	ENVIRONMENTAL			
Thermal shock.	See Note.	EIA-364-32, Test Condition I.		
		Subject mated specimens to 10		
		cycles between -55 and 85°C with		
		30 minute dwells at temperature		
		extremes and 1 minute transition		
		between temperatures.		
Humidity/temperature cycling.	See Note.	EIA-364-31, Method III.		
		Subject mated specimens to 10		
		cycles (10 days) between 25 and		
		65°C at 80 to 100% RH.		
Temperature life.	See Note.	EIA-364-17, Method A, Test		
		Condition 3, Test Time Condition C.		
		Subject mated specimens to 85°C		
		for 500 hours.		

Figure 1 (cont'd)

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Test Description	Requirement	Procedure
Mixed flowing gas.	See Note.	EIA-364-65, Class IIA (4 gas). Subject specimens to environmental Class IIA for 20 days, 10 days unmated followed by 10 days mated.
Thermal disturbance.	See Note.	Subject mated and board mounted specimens to 10 temperature cycles between 15 ± 3°C and 85 ± 3°C as measured on the part. Ramp times shall be a minimum of 2°C per minute with dwell times long enough to ensure contacts reach the temperature extremes (5 minutes minimum). Humidity not controlled.



NOTE

Shall meet visual requirements, show no physical damage, and meet requirements of additional tests as specified in the Product Qualification and Requalification Test Sequence shown in Figure 2.

Figure 1 (end)

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3.6. Product Qualification and Requalification Test Sequence

Test or Examination	Test Group (a)					
	1	2	3	4	5	6
	Test Sequence (b)					
Initial examination of product	1	1	1	1	1	1
LLCR	4(e),6, 8(f),11	2(e),5	2(e),5			
Insulation resistance				2,6		
Withstanding voltage				3,7		
Random vibration	9					
Mechanical shock	10					
Durability, 100 cycles total	7(c)					
Durability, 250 cycles total						5(g),9(g)
Mating force	2,12					
Unmating force	3,13					
Retention, axial						2,6,10
Retention, perpendicular						3,7,11
Latch strength						4,8,12
Press fit insertion force					2	
Press fit extraction force					3	
Thermal shock		3(d)		4		
Humidity/temperature cycling		4		5		
Temperature life	5					
Mixed flowing gas			3 (d)			
Thermal disturbance			4			
Final examination of product	14	6	6	8	4	13



NOTE

- (a) See paragraph 4.1.A.
- (b) Numbers indicate sequence in which tests are performed.
- (c) Mate and unmate specimens for 43 cycles, measure LLCR (baseline), change transceivers and mate and unmate for an additional 50 cycles.
- (d) Precondition specimens with 25 durability cycles with latches engaged.
- (e) Precondition specimens with 5 durability cycles with latches engaged.
- (f) Measure using original transceiver.
- (g) Mate and unmate specimens for 125 durability cycles.

Figure 2

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4. QUALITY ASSURANCE PROVISIONS

4.1. Qualification Testing

A. Specimen Selection

Specimens shall be prepared in accordance with applicable Instruction Sheets and shall be selected at random from current production. Test groups 1-5 shall consist of 5 specimens each with 10 transceivers for test group 1 durability testing. Test group 6 shall consist of 4 specimens each.

B. Test Sequence

Qualification inspection shall be verified by testing specimens as specified in Figure 2.

4.2. Requalification Testing

If changes significantly affecting form, fit or function are made to the product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of the original testing sequence as determined by development/product, quality and reliability engineering.

4.3. Acceptance

Acceptance is based on verification that the product meets the requirements of Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and specimens resubmitted for qualification. Testing to confirm corrective action is required before resubmittal.

4.4. Quality Conformance Inspection

The applicable quality inspection plan shall specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification.

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